INTEGRATED CIRCUITS



Product specification Supersedes data of 1990 Nov 26 IC15 Data Handbook 1999 Jan 08



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Philips Semiconductors

74F455,* 74F456

74F455 Octal Buffer/Driver with Parity, Inverting (3-State) 74F456 Octal Buffer/Driver with Parity, Non-Inverting (3-State)

FEATURES

- High impedance NPN base inputs for reduced loading (40μA in High and Low states)
- 74F456 combines 74F244 and 74F280A functions in one package
- 74F456 is a center pin version of the 74F656A
- 74F456 Non-Inverting
- 3-State outputs sink 64mA and source 15mA
- 24-pin plastic Slim DIP (300 mil) package
- Broadside pinout simplifies PC board layout

DESCRIPTION

The 74F455 and 74F456 are octal buffers and line drivers with parity generation/checking designed to be employed as memory address drivers, clock drivers and bus-oriented transmitters/receivers. These parts include parity generator/checker to improve PC board density.

| ТҮРЕ | TYPICAL PROPAGATION DELAY | TYPICAL SUPPLY CURRENT (TOTAL) |
|--------|---------------------------------|-----------------------------------|
| 74F455 | 6.5ns | 64mA |
| 74F456 | 7.5ns | 64mA |

ORDERING INFORMATION

| DESCRIPTION | COMMERCIAL RANGE V _{CC} = 5V ±10%, T _{amb} = 0°C to +70°C | PKG DWG # | | |
|-------------------------------------|--|-----------|--|--|
| 24-pin plastic Slim DIP (300mil) | N74456N | SOT222-1 | | |
| 24-pin plastic SOL | N74456D | SOT137-1 | | |

INPUT AND OUTPUT LOADING AND FAN-OUT TABLE

| PINS | DESCRIPTION | 74F(U.L.) HIGH/LOW | LOAD VALUE HIGH/LOW |
|-------------------------------|-----------------------------------|-----------------------|------------------------|
| D0D7 | Data inputs | 2.0/0.066 | 40μΑ/40μΑ |
| PI | Parity input | 1.0/0.033 | 20μΑ/20μΑ |
| OE0, OE1 | Output Enable inputs (active Low) | 1.0/0.033 | 20μΑ/20μΑ |
| ΣΕ, ΣΟ | Parity outputs | 750/106.7 | 15mA/64mA |
| $\overline{Q}0-\overline{Q}7$ | Data outputs (75F455) | 750/106.7 | 15mA/64mA |
| Q0–Q7 | Data outputs (75F456) | 750/106.7 | 15mA/64mA |

NOTE: One (1.0) FAST Unit Load (U.L.) is defined as 20µA in the High state and 0.6mA in the Low state.

PIN CONFIGURATION – 74F455



PIN CONFIGURATION – 74F456

| OE0 1 | | ΣΟ |
|-------------------|-----|-------|
| 0E1 2 | 23 | ΣE |
| PI 3 | 22 | 2 Q0 |
| D0 4 | 2' |] Q1 |
| D1 5 | 20 | Q2 |
| D2 6 | 19 | GND |
| V _{CC} 7 | 18 | 3 GND |
| D3 8 | 17 | 7 Q3 |
| D4 9 | 16 | 3 Q4 |
| D5 10 | 15 | § Q5 |
| D6 [11 | 14 | 4 Q6 |
| D7 12 | 1: | 3 Q7 |
| | | |
| | SF0 | 0958 |

* Discontinued part. Please see the Discontinued Products List. 1999 Jan 08

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LOGIC SYMBOL - 74F455



LOGIC SYMBOL (IEEE/IEC) - 74F455



FUNCTION TABLE

| | INPUTS | OUTPUTS | | | |
|-----|--------|---------|--------|----|--|
| | | 74F455 | 74F456 | | |
| OE0 | OE1 | Dn | Qn | Qn | |
| L | L | L | Н | L | |
| L | L | Н | L | Н | |
| н | X X | | Z | Z | |
| Х | Н | Х | Z | Z | |

H = High voltage level

L = Low voltage level Z = High impedance "off" state

X = Don't care

LOGIC SYMBOL - 74F456



LOGIC SYMBOL (IEEE/IEC) - 74F456

| _3 | P3 | 3,5,6,7,8 9,10,11,12 3,5,6,7,8 9,10,11,12 | ^{2K} [EVEN] ▽ [ODD] ▽ | 23 24 |
|-----------------------------------|--|--|--------------------------------------|--|
| 1 N 2 N | ≽1 | EN4 | | |
| 4 5 6 8 9 10 11 | Z5 Z6 Z7 Z8 Z9 Z10 Z11 | | 4 🗸 | 22 21 20 17 16 15 14 |
| _12 | Z12 | | | 13 SF00962 |

FUNCTION TABLE for PARITY OUTPUTS

| INPUTS | OUTF | PUTS |
|--------------------------------------|------|------|
| Number of inputs, High (PI, D0 - D7) | ΣΕ | ΣΟ |
| Even - 0, 2, 4, 6, 8 | Н | L |
| Odd - 1, 3, 5, 7, 9 | L | Н |
| Any $\overline{OE}n = High$ | Z | Z |

H = High voltage level

L = Low voltage level

Z = High impedance "off" state X = Don't care

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LOGIC DIAGRAM for 74F455



^{*} Discontinued part. Please see the Discontinued Products List.

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LOGIC DIAGRAM for 74F456



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ABSOLUTE MAXIMUM RATINGS

(Operation beyond the limits set forth in this table may impair the useful life of the device. Unless otherwise noted these limits are over the operating free-air temperature range.)

| SYMBOL | PARAMETER | RATING | UNIT | |
|------------------|--|--------------------------|------|--|
| V _{CC} | Supply voltage | -0.5 to +7.0 | V | |
| V _{IN} | Input voltage | -0.5 to +7.0 | V | |
| I _{IN} | Input current | -30 to +5 | mA | |
| V _{OUT} | Voltage applied to output in High output state | -0.5 to +V _{CC} | V | |
| I _{OUT} | Current applied to output in Low output state | 128 | mA | |
| T _{amb} | Operating free-air temperature range | 0 to +70 | °C | |
| T _{stg} | Storage temperature range | -65 to +150 | °C | |

RECOMMENDED OPERATING CONDITIONS

| SYMBOL | DADAMETED | | LINUT | | |
|------------------|--------------------------------------|-----|-------|-----|------|
| STMBOL | PARAMETER | MIN | NOM | MAX | UNIT |
| V _{CC} | Supply voltage | 4.5 | 5.0 | 5.5 | V |
| V _{IH} | High-level input voltage | 2.0 | | | V |
| V _{IL} | Low-level input voltage | | | 0.8 | V |
| I _{IK} | Input clamp current | | | -18 | mA |
| I _{OH} | High-level output current | | | -15 | mA |
| I _{OL} | Low-level output current | | | 64 | mA |
| T _{amb} | Operating free-air temperature range | 0 | | 70 | °C |

^{*} Discontinued part. Please see the Discontinued Products List.

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DC ELECTRICAL CHARACTERISTICS

(Over recommended operating free-air temperature range unless otherwise noted.)

| | PARAMETER TEST CONDITIONS ¹ | | | | | | LIMITS | | | |
|------------------|--|---------------------------|---|------------------------|---------------------|-------|--------|------|----|--|
| SYMBOL | PARAMETER | IES | MIN | TYP ² | MAX | UNIT | | | | |
| | | | V _{CC} = MIN, | | ±10%V _{CC} | 2.4 | | | V | |
| V _{OH} | High-level output voltage | | $V_{IL} = MAX,$ | I _{OH} =–3mA | ±5%V _{CC} | 2.7 | 3.3 | | V | |
| | | | $V_{\rm IH} = \rm MIN$ | I _{OH} =-15mA | ±10%V _{CC} | 2.0 | | | V | |
| | | | $V_{CC} = MIN,$ | | ±10%V _{CC} | | | 0.55 | V | |
| V _{OL} | Low-level output voltage | | V _{IL} = MAX, V _{IH} = MIN | I _{OL} = MAX | ±5%V _{CC} | | 0.42 | 0.55 | V | |
| V _{IK} | Input clamp voltage | $V_{CC} = MIN, I_I$ | = I _{IK} | | | -0.73 | -1.2 | V | | |
| lı | Input current at maximum input | V _{CC} = 0.0V, V | = 0.0V, V _I = 7.0V | | | | 100 | μΑ | | |
| l | High-level input current | | V _{CC} = MAX, V _I = 2.7V | | | | | 40 | μA | |
| ιн | High-level input current | | | | | | 20 | μA | | |
| l | Low-level input current | Dn | V _{CC} = MAX, V _I = 0.5V | | | | | -40 | μΑ | |
| IIL | Low-level input current | PI, OEn | $v_{\rm CC} = war, v$ | | | -20 | μΑ | | | |
| I _{OZH} | Off-state output current High-level voltage applied | | V _{CC} = MAX, V | / _O = 2.7V | | | | 50 | μA | |
| I _{OZL} | Off-state output current Low-level voltage applied | | V _{CC} = MAX, V _O = 0.5V | | | | | -50 | μA | |
| I _{OS} | Short-circuit output current ³ | | $V_{CC} = MAX$ | V _{CC} = MAX | | -100 | | -225 | mA | |
| | | I _{ССН} | V _{CC} = MAX | | | | 50 | 80 | mA | |
| I _{CC} | Supply current (total) | I _{CCL} | | | | | 78 | 110 | mA | |
| | |] | | | | 63 | 90 | mA | | |

NOTES:

1. For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions for the applicable type.

2. All typical values are at $V_{CC} = 5V$, $T_{amb} = 25^{\circ}C$.

3. Not more than one output should be shorted at a time. For testing I_{OS}, the use of high-speed test apparatus and/or sample-and-hold techniques are preferable in order to minimize internal heating and more accurately reflect operational values. Otherwise, prolonged shorting of a High output may raise the chip temperature well above normal and thereby cause invalid readings in other parameter tests. In any sequence of parameter tests, I_{OS} tests should be performed last.

AC ELECTRICAL CHARACTERISTICS

| | | | | | | LIM | ITS | | |
|--------------------------------------|--|-------------------|---|---|-------------------|--|------------|--------------|----|
| SYMBOL | PARAMETER | TEST CONDITION | \ T _a C _L = 5 | / _{CC} = +5` _{mb} = +25 0pF, R _L : | V ≌C = 500Ω | V _{CC} = +5 T _{amb} = 0°0 C _L = 50pF, | UNIT | | |
| | | | MIN | TYP | MAX | MIN | MAX | | |
| t _{PLH} t _{PHL} | Propagation delay Dn to Qn74F455Propagation delay Dn to Qn74F456 | | Waveform 2 | 2.0 1.0 | 4.5 2.0 | 6.5 4.0 | 2.0 1.0 | 7.5 4.5 | ns |
| t _{PLH} t _{PHL} | | | Waveform 1 | 2.0 2.5 | 4.5 5.0 | 6.5 7.0 | 2.0 2.5 | 7.0 7.5 | ns |
| t _{PLH} t _{PHL} | Propagation delay Dn to ΣE , ΣO | | | 5.5 5.5 | 10.0 11.0 | 13.0 14.5 | 5.5 5.5 | 14.0 16.5 | ns |
| t _{PZH} t _{PZL} | Output Enable time to High or Low level | | Waveform 3 Waveform 4 | 2.5 4.0 | 4.0 8.0 | 8.0 10.5 | 2.5 4.0 | 9.0 11.5 | ns |
| t _{PHZ} t _{PLZ} | Output Disable time from High or Low level | | Waveform 3 Waveform 4 | 1.5 2.0 | 4.0 5.0 | 6.5 7.5 | 1.5 2.0 | 7.5 8.0 | ns |

^{*} Discontinued part. Please see the Discontinued Products List.

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AC WAVEFORMS









TEST CIRCUIT AND WAVEFORMS







Waveform 4. 3-State Output Enable Time to Low Level and Output Disable Time from Low Level



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| UNIT | max. | min. | max. | b | b 1 | с | D ⁽¹⁾ | E ⁽¹⁾ | е | e ₁ | L | ME | M _H | w | max. |
|--------|-------|-------|-------|----------------|----------------|----------------|------------------|------------------|-------|----------------|----------------|--------------|----------------|------|-------|
| mm | 4.70 | 0.38 | 3.94 | 1.63 1.14 | 0.56 0.43 | 0.36 0.25 | 31.9 31.5 | 6.73 6.48 | 2.54 | 7.62 | 3.51 3.05 | 8.13 7.62 | 10.03 7.62 | 0.25 | 2.05 |
| inches | 0.185 | 0.015 | 0.155 | 0.064 0.045 | 0.022 0.017 | 0.014 0.010 | 1.256 1.240 | 0.265 0.255 | 0.100 | 0.300 | 0.138 0.120 | 0.32 0.30 | 0.395 0.300 | 0.01 | 0.081 |

Note

1. Plastic or metal protrusions of 0.01 inches maximum per side are not included.

| OUTLINE VERSION | REFERENCES | | | | EUROPEAN | ISSUE DATE |
|--------------------|------------|----------|------|--|------------|------------|
| | IEC | JEDEC | EIAJ | | PROJECTION | ISSUE DATE |
| SOT222-1 | | MS-001AF | | | | 95-03-11 |

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Product specification

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NOTES

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Data sheet status

| Data sheet status | Product status | Definition ^[1] |
|---------------------------|-------------------|---|
| Objective specification | Development | This data sheet contains the design target or goal specifications for product development. Specification may change in any manner without notice. |
| Preliminary specification | Qualification | This data sheet contains preliminary data, and supplementary data will be published at a later date. Philips Semiconductors reserves the right to make chages at any time without notice in order to improve design and supply the best possible product. |
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[1] Please consult the most recently issued datasheet before initiating or completing a design.

Definitions

Short-form specification — The data in a short-form specification is extracted from a full data sheet with the same type number and title. For detailed information see the relevant data sheet or data handbook.

Limiting values definition — Limiting values given are in accordance with the Absolute Maximum Rating System (IEC 134). Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or at any other conditions above those given in the Characteristics sections of the specification is not implied. Exposure to limiting values for extended periods may affect device reliability.

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